

Test Probe INGUN E-Type

E-075 291 064 E 2000

Item E-075-0077



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Partner for Future Technology

- Highest contact reliability under challenging test conditions without additional stress on the DUT: up to 25% larger contact surface between test probe and DUT
- When hitting the test surface a spring force up to 100% higher than a standard GKS is available, but the same spring force as a standard GKS is achieved at the working stroke.



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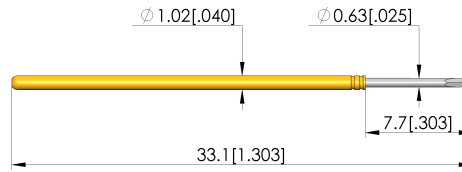


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General data

Product group	ICT / FCT (in-circuit test and function test)
Sub-product group	E-Type
Series	E-075
Grid	1.91 mm [75 mil]
Contacting from	Pad, via
Magnetic	Yes
Installation type	Plug-in
Quick-exchange system	Yes
Adjustable installation height	No
Non-rotating	No
Compatible receptacle(s)	KS-075
Min. temperature	- 40 °C [- 104 °F]
Max. temperature	+ 80 °C [+ 176 °F]
RoHS-compliant	Yes



Electrical data

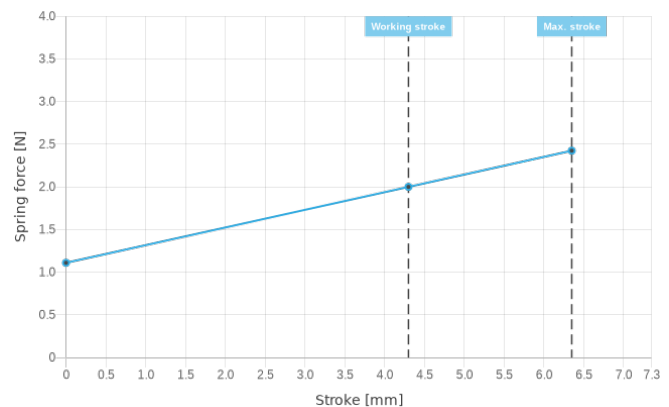
Current load capacity / rated current	3 A
Typical resistance (Ri)	<20 mOhm

Mechanical data

Total length	33.1 mm [1.30 in]
Barrel diameter	1.02 mm [.040 in]
Maximum stroke	6.35 mm [.25 in]
Spring pre-load	1.2 N [4.31 ozf]
Collar height	00
Spring force at working stroke	2 N [7.19 ozf]
Recommended working stroke	4.3 mm [.169 in]

Tip style data

Tip style	91 dagger, self-cleaning
Tip diameter	0.64 mm [.025 in]
Tip style surface	E palladium / nickel
Tip style material	2 steel



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Prices and delivery times on request.
Technical changes reserved. 11/22 EN

Weitere Informationen zum Thema
ICT/FCT Test probes

